## Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/539,166	LEE ET AL.	
Examiner	Art Unit	
SHICK C. HOM	2616	

SEARCHED					
Class	Subclass	Date	Examiner		
370	344	9/11/2008	SH		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examine	
See sea	ext search - rch history ntout	9/11/2008	ѕн	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
,	DATE	EXMR		
EAST (USPT, US-PGPUB) - See search history printout	9/11/2008	SH		
Inventor search - See search history printout	9/11/2008	SH		